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U.S. DEPARTMENT OF
ENERGY

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DC/DC Conversion (bPOL, 11V → 1.5V)

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The Goal

- bPOL is a single-phase synchronous buck converter designed for HEP experiments (variable voltage → constant lower voltage and variable current) that is controlled by AMAC chip
 - Replacement for FEAST2 line
 - Max input voltage recommended is 11V (can technically handle 12V)
 - Max output current recommended is 4A
 - Converts variable DC voltage into constant lower DC voltage with variable current
 - Operates by applying pulse width modulated (PWM) waveform of duty cycle to low pass LC filter
 - Switch is connected to input voltage and inductor
 - Downside of buck converter: noisy
 - Nature of switching regulators

The Goal (cont.)

- Want to describe efficiency of DC/DC conversion performed by bPOL from 11V to 1.5V in terms of temperature (from **Proportional To Absolute Temperature sensor**) and output current
 - Want efficiency fit to be true for detector temperature range (-40°C to 40°C)

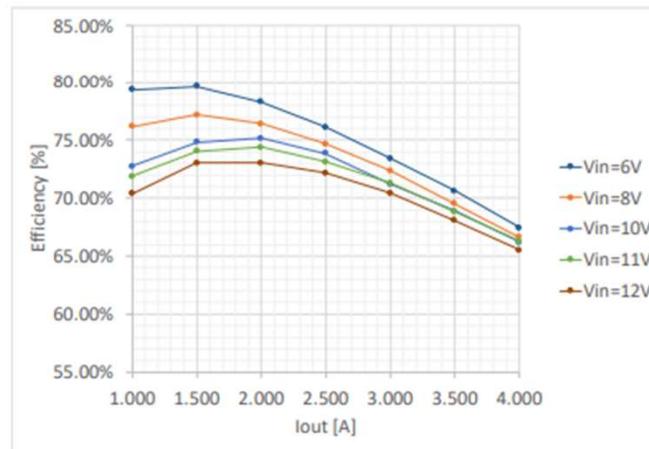
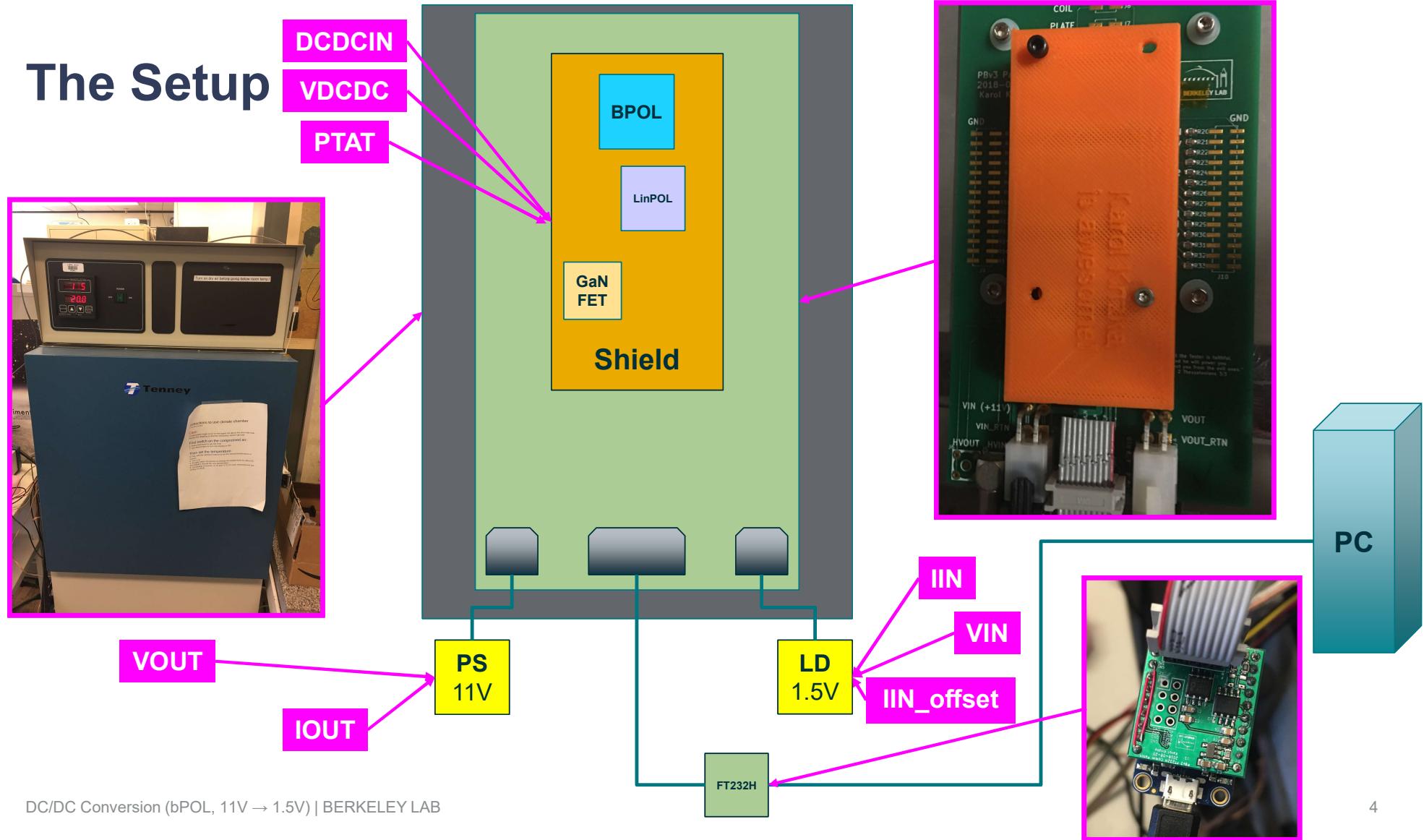


Figure 27: ASIC Efficiency for the $V_{out}=1.5V$ version (without input+output π filters) and different V_{in} and I_{out} with the module in good thermal contact with a cooling plate at about 20°C.

The Setup



Wrangling the chiller

Takes much longer than one would think

- Settings on chiller in strips lab are the same as chiller in pixel lab, but are not capable of sustaining the same temperature range
 - -30°C to -40°C impossible, 30°C to 40°C difficult
 - This means the range of temperature tests is truncated to -15°C to 35°C
- Two primary differences: cable hole stopper, and chiller maintenance
 - Cable hole stopper in pixel lab is rubber stopper, cable hole stopper in strips lab are pieces of foam
 - Sometimes foam pieces are pushed out by compressed air
 - Makes a difference, but doesn't fully account for malfunction
 - Chiller maintenance is done on individual chillers, not both uniformly, and tests generally only use one of the two chillers
 - Service being planned to ensure circulation is where it should be, etc.

Taking data well

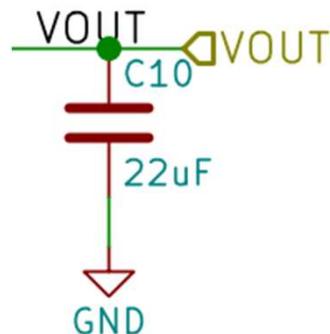
Limited temperature ranges, different efficiencies, calibration, wait times, and temperature ramp

- Take temperature data based on PTAT reading rather than set temperature on chamber
 - For bin X, all data points corresponding to PTAT readings of $X - 2.5^{\circ}\text{C}$ to $X + 2.5^{\circ}\text{C}$
 - This requires a lot of repetition due to temperature ramp from internal heating
- Use and correct the eff1 measurement calculated in [pbv3_eff_temp_scan.cpp \(powertools\)](#)
 - Two efficiency values calculated
 - eff1 is dependent on VOUT, IOUT, VIIN, IIN, and IIN_offset (Id, Id, ps, ps, ps)
 - eff2 is dependent on VDCDC, IOUT, DCDCIN, IIN, and IIN_offset (amac, Id, amac, ps, ps)
 - Id measurements are from the DC variable load BK85xxx
 - ps measurements are from the power supply
 - amac measurements are from the ADCs on the AMAC chip

Taking data well (cont.)

Limited temperature ranges, different efficiencies, calibration, wait times, and temperature ramp

- When probing output voltage on the board at C10 with multimeter when DCDC set to 0A, voltage matches VOUT
 - C10 = 1.57V, VOUT = 1.57V, VDCDC = 1.35V
 - Conclusion: use eff1
- Modified eff1 to account for voltage drop across the long copper trace
 - At IOUT = 3.5A, C10 = 1.54V, VOUT = 1.26V
 - Graphed |VOUT – C10| vs. IOUT to find trace resistance (slope) was 0.0775Ω
 - » Accounted for the 0.0775Ω offset by using $(VOUT + 0.0775 \cdot IOUT)$ instead of VOUT



Taking data well (cont.)

Limited temperature ranges, different efficiencies, calibration, wait times, and temperature ramp

- Run calibrations in [pbv3_tune.cpp](#) a singular time before data collection commences
 - [calibrateSlope](#), [calibrateOffset](#), [tuneVDDBG](#), [tune AMBG](#), [tuneRampGain](#), [calibrateNTC](#), [calibrateTemperature](#)
- Run [calibrateAMACslope](#) at the beginning of each data collection set (multiple collection sets in while loop)
 - Should saturate at 1023 counts around 0.9V input voltage
 - Prior to running tunings, AMAC slope wasn't saturating, reaching 850 counts at 1V
 - Usually takes three minutes to stabilise
 - Modified data collection approach to accommodate this
- Each measurement (multiple measurements per collection set) must stabilise at a given output current before the data is taken

Taking data well (cont.)

Limited temperature ranges, different efficiencies, calibration, wait times, and temperature ramp

- Temperature increases non-uniformly with output current due to internal heating
 - Due to non-uniform heating, scanning current is hard for data collection
 - Scanning temperature for a fixed current value is possible, but takes a while
 - Chiller temperature must stabilise before data collection
 - Solution: Scan currents that satisfy specific temperature bins, and then grossly scan temperature

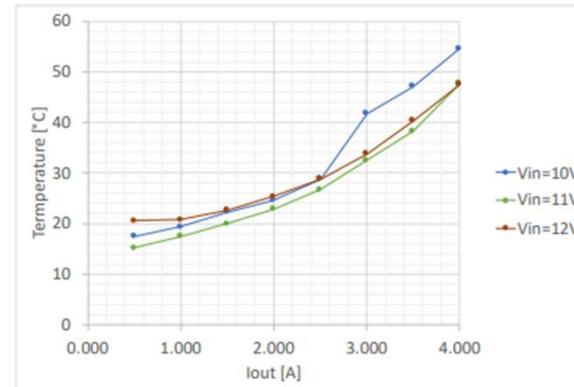
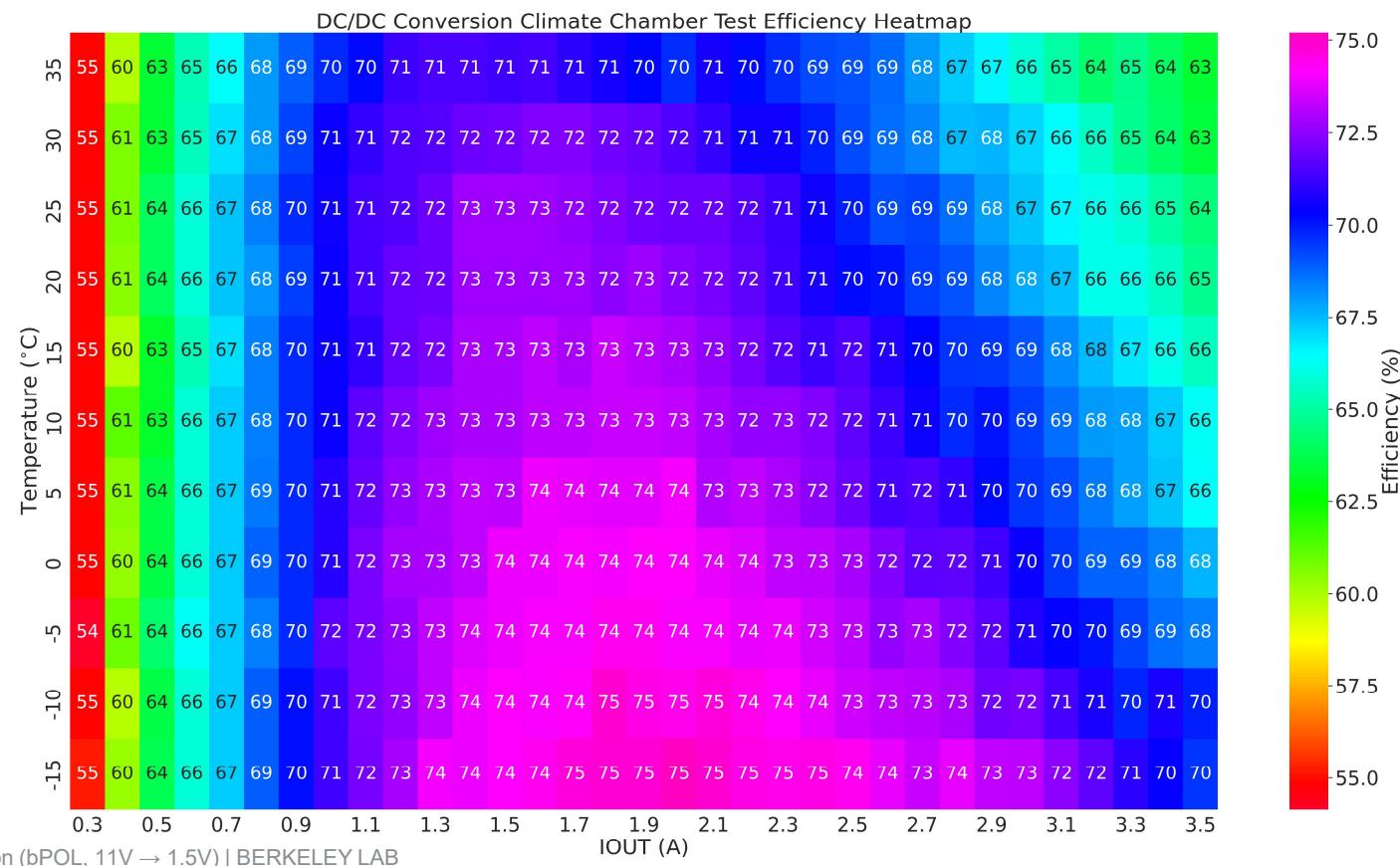


Figure 26: Increase of temperature for the $V_{out}=1.5V$ version with V_{in} and I_{out} , with the module in good thermal contact with a cooling plate at about $20^{\circ}C$.

Efficiency Heatmap



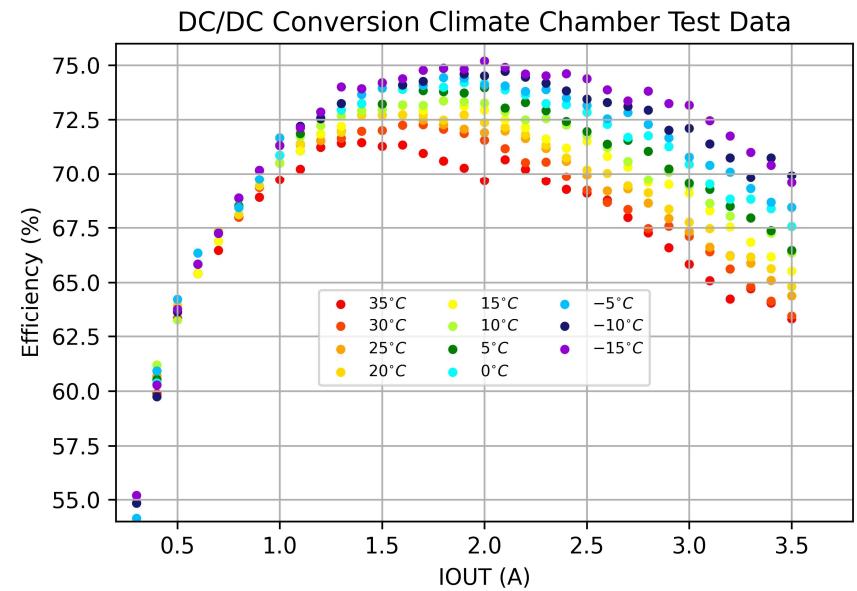
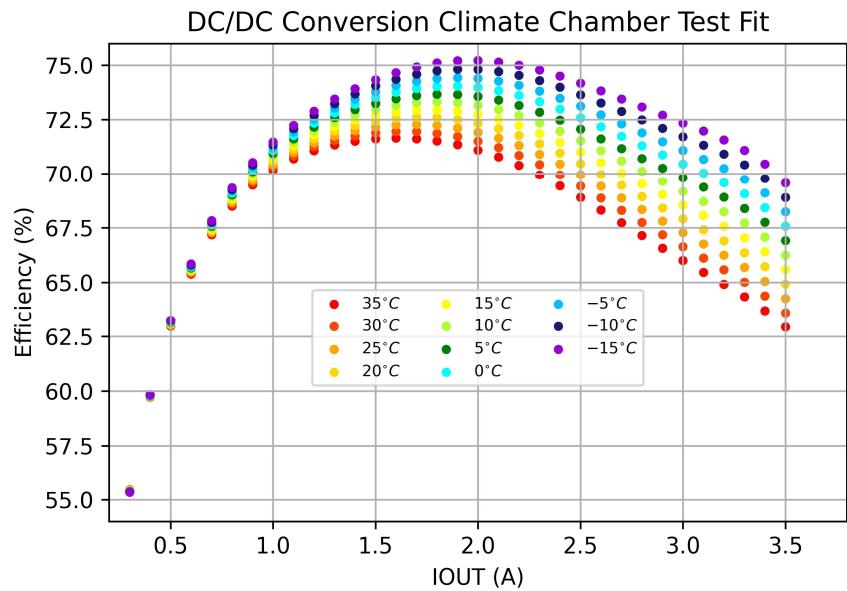
Fit equation

P is PTAT ($^{\circ}\text{C}$), I is I_{OUT} (A)

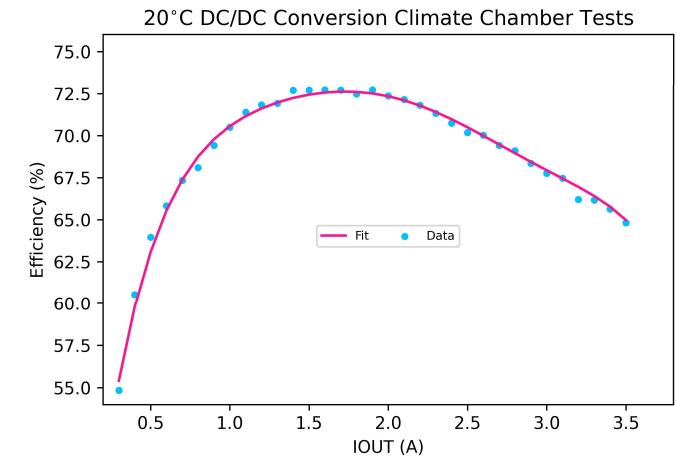
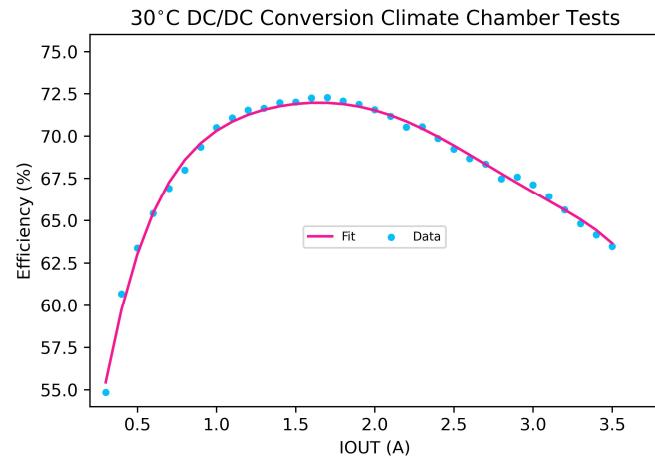
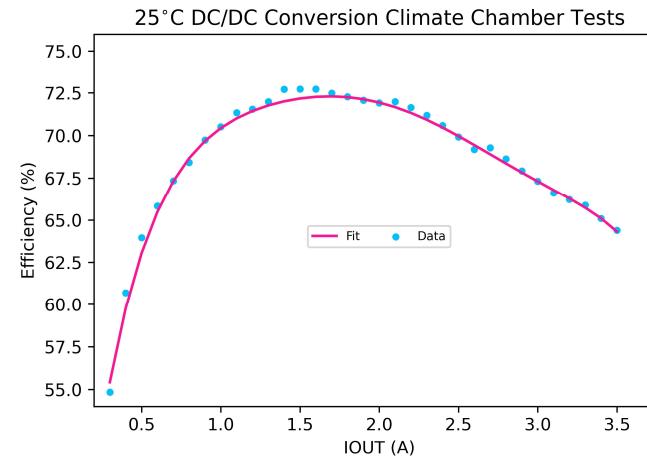
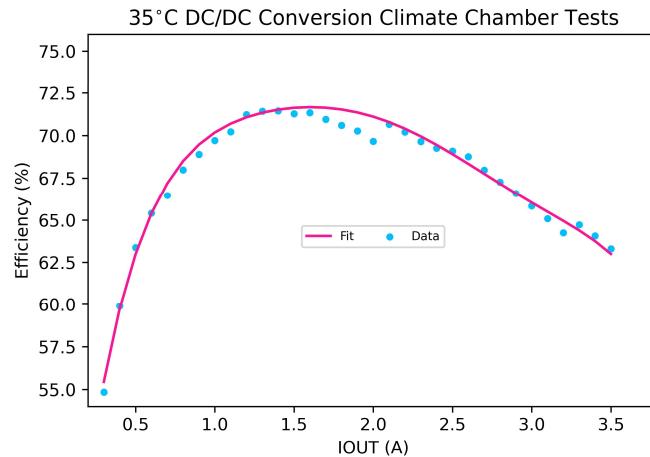
$$E(P, I)$$

$$\begin{aligned} &= (0.00245273 \cdot P - 0.56929)I^6 + (-0.0268157 \cdot P + 7.1382)I^5 + (0.112837 \cdot P - 35.8580)I^4 \\ &\quad + (-0.224422 \cdot P + 92.854)I^3 + (0.206925 \cdot P - 134.97)I^2 + (-0.122281 \cdot P + 110.298)I \\ &\quad + (0.0254751 \cdot P + 32.1888) \end{aligned}$$

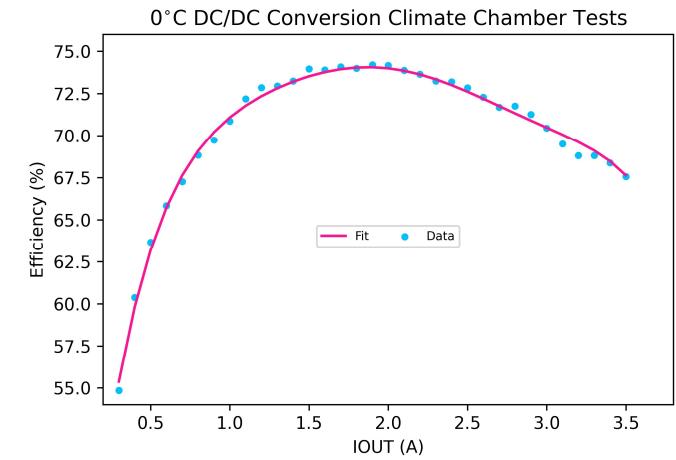
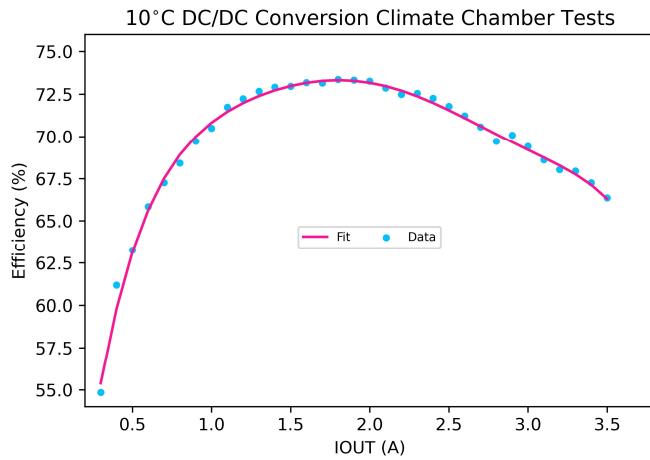
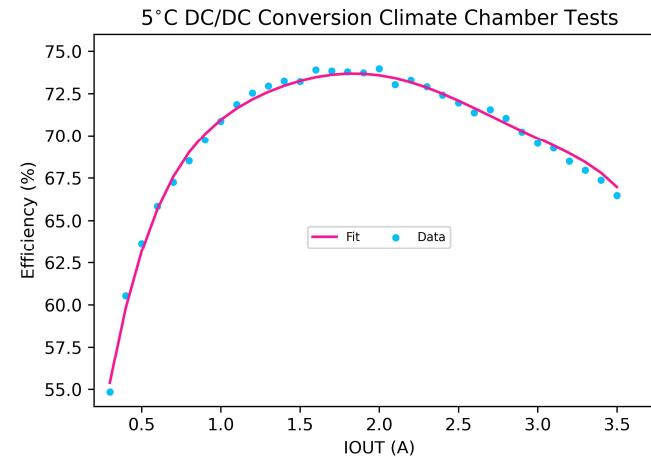
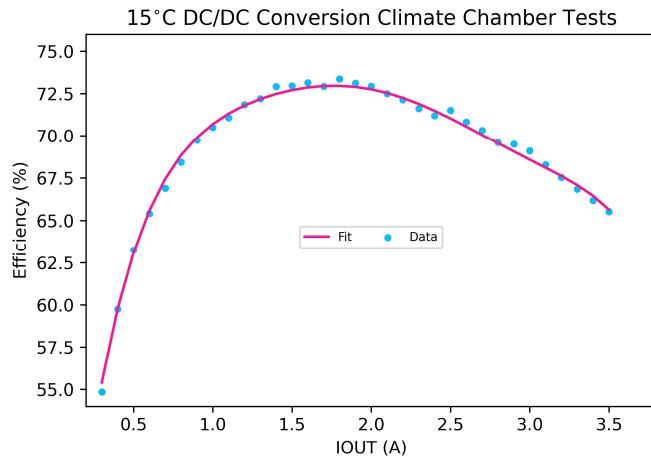
Fit vs. Data



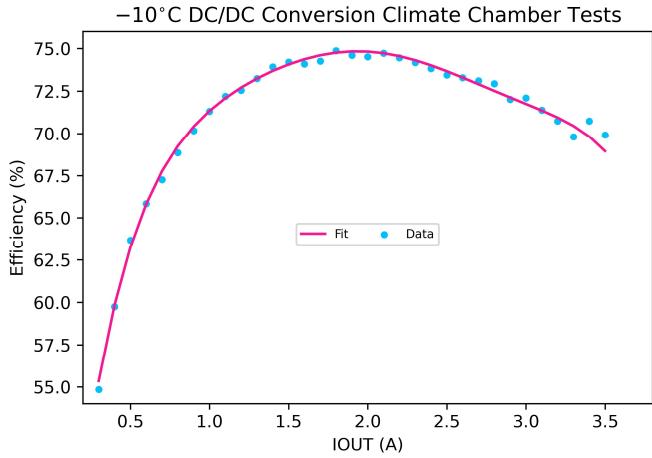
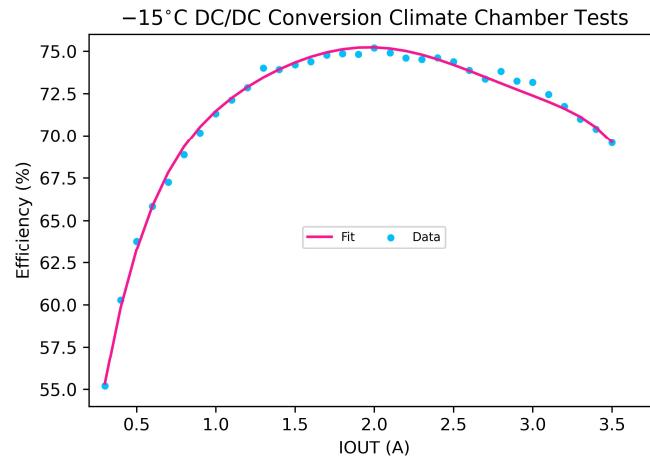
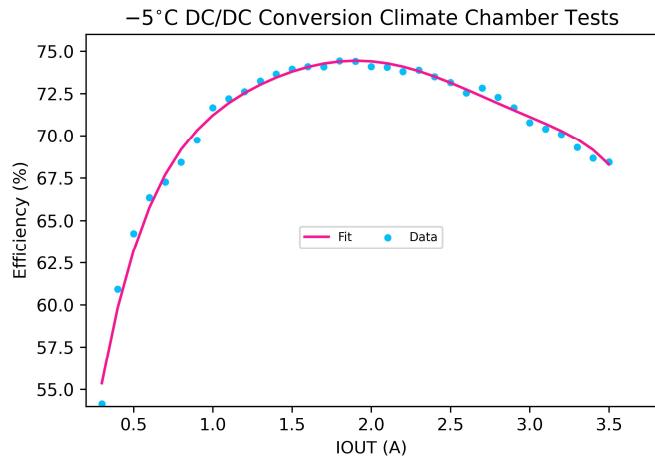
Fit vs. Data (above room temp)



Fit vs. Data (freezing to room temp)



Fit vs. Data (below freezing)



Thank You!